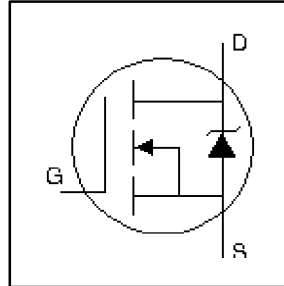


HEXFET® Power MOSFET

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30V  $V_{GS}$  Rating
- Reduced  $C_{iss}$ ,  $C_{oss}$ ,  $C_{rss}$
- Isolated Central Mounting Hole
- Dynamic  $dv/dt$  Rated
- Repetitive Avalanche Rated



$$V_{DSS} = 400V$$

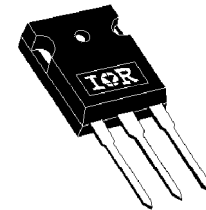
$$R_{DS(on)} = 0.20\Omega$$

$$I_D = 23A$$

**Description**

This new series of Low Charge HEXFET Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Hexfet technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of HEXFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



TO-247AC

**Absolute Maximum Ratings**

|                             | Parameter                                | Max.                  | Units         |
|-----------------------------|------------------------------------------|-----------------------|---------------|
| $I_D$ @ $T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS}$ @ 10V | 23                    | A             |
| $I_D$ @ $T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS}$ @ 10V | 14                    |               |
| $I_{DM}$                    | Pulsed Drain Current ①                   | 92                    |               |
| $P_D$ @ $T_C = 25^\circ C$  | Power Dissipation                        | 280                   | W             |
|                             | Linear Derating Factor                   | 2.2                   | W/ $^\circ C$ |
| $V_{GS}$                    | Gate-to-Source Voltage                   | $\pm 30$              | V             |
| $E_{AS}$                    | Single Pulse Avalanche Energy ②          | 1200                  | mJ            |
| $I_{AR}$                    | Avalanche Current ③                      | 23                    | A             |
| $E_{AR}$                    | Repetitive Avalanche Energy ①            | 28                    | mJ            |
| $dv/dt$                     | Peak Diode Recovery $dv/dt$ ③            | 4.0                   | V/ns          |
| $T_J$                       | Operating Junction and                   | -55 to + 150          | $^\circ C$    |
| $T_{STG}$                   | Storage Temperature Range                |                       |               |
|                             | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case) |               |
|                             | Mounting torque, 6-32 or M3 screw.       | 10 lbf•in (1.1N•m)    |               |

**Thermal Resistance**

|                 | Parameter                           | Min. | Typ. | Max. | Units        |
|-----------------|-------------------------------------|------|------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | —    | 0.45 | $^\circ C/W$ |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | —    | 0.24 | —    |              |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | —    | —    |              |

# IRFP360LC



## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units               | Conditions                                                         |
|---------------------------------|--------------------------------------|------|------|------|---------------------|--------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 400  | —    | —    | V                   | $V_{GS} = 0V, I_D = 250\mu A$                                      |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.49 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1mA$                      |
| $R_{DS(ON)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.20 | $\Omega$            | $V_{GS} = 10V, I_D = 14A$ ④                                        |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                                  |
| $g_{fs}$                        | Forward Transconductance             | 13   | —    | —    | S                   | $V_{DS} = 50V, I_D = 14A$                                          |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$             | $V_{DS} = 400V, V_{GS} = 0V$                                       |
|                                 |                                      | —    | —    | 250  |                     | $V_{DS} = 320V, V_{GS} = 0V, T_J = 125^\circ\text{C}$              |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                  | $V_{GS} = 20V$                                                     |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |                     | $V_{GS} = -20V$                                                    |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 110  | nC                  | $I_D = 23A$                                                        |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 28   |                     | $V_{DS} = 320V$                                                    |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 45   |                     | $V_{GS} = 10V$ , See Fig. 6 and 13 ④                               |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 16   | —    |                     | $V_{DD} = 200V$                                                    |
| $t_r$                           | Rise Time                            | —    | 75   | —    | ns                  | $I_D = 23A$                                                        |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 42   | —    |                     | $R_G = 4.3\Omega$                                                  |
| $t_f$                           | Fall Time                            | —    | 50   | —    |                     | $R_D = 7.9\Omega$ , See Fig. 10 ④                                  |
| $L_D$                           | Internal Drain Inductance            | —    | 5.0  | —    | nH                  | Between lead, 6mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 13   | —    |                     |                                                                    |
| $C_{iss}$                       | Input Capacitance                    | —    | 3400 | —    | pF                  | $V_{GS} = 0V$                                                      |
| $C_{oss}$                       | Output Capacitance                   | —    | 540  | —    |                     | $V_{DS} = 25V$                                                     |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 42   | —    |                     | $f = 1.0MHz$ , See Fig. 5                                          |



## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.                                                                        | Typ. | Max. | Units   | Conditions                                                     |
|----------|----------------------------------------|-----------------------------------------------------------------------------|------|------|---------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                           | —    | 23   | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                           | —    | 92   |         |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                           | —    | 1.8  | V       | $T_J = 25^\circ\text{C}, I_S = 23A, V_{GS} = 0V$ ④             |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                           | 400  | 600  | ns      | $T_J = 25^\circ\text{C}, I_F = 23A$                            |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                           | 5.7  | 8.6  | $\mu C$ | $di/dt = 100A/\mu s$ ④                                         |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |         |                                                                |

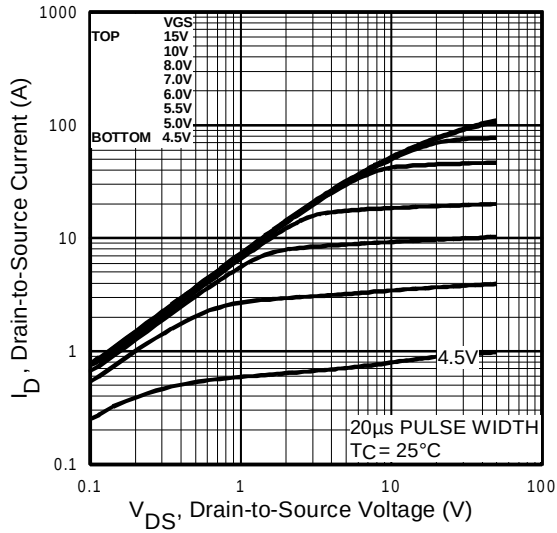
### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

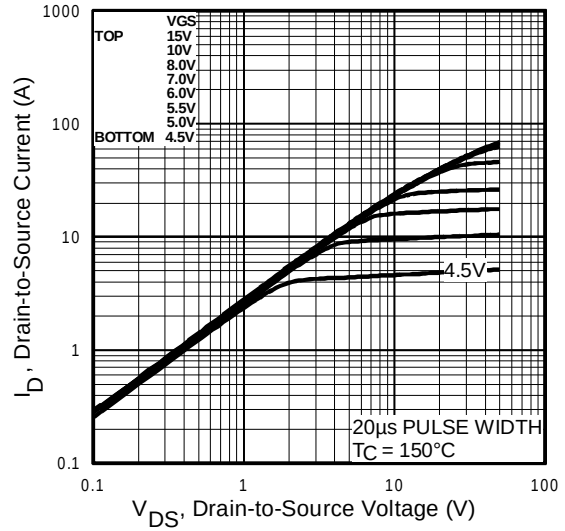
③  $I_{SD} \leq 23A, di/dt \leq 170A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$

②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 4.0mH$   
 $R_G = 25\Omega, I_{AS} = 23A$ . (See Figure 12)

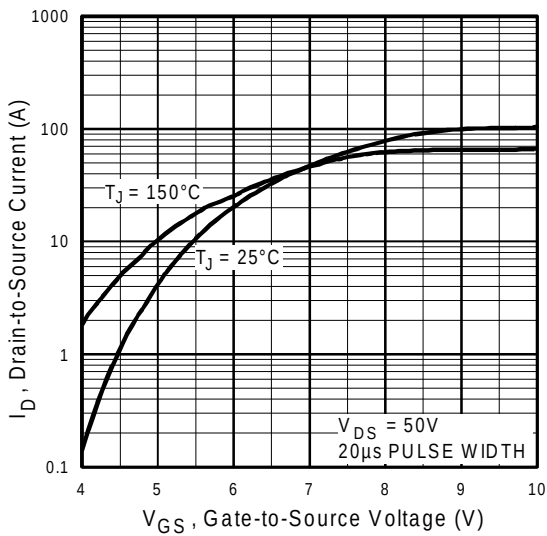
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



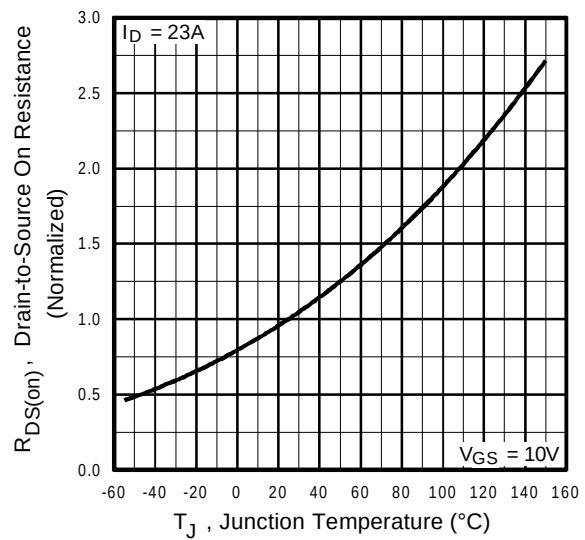
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



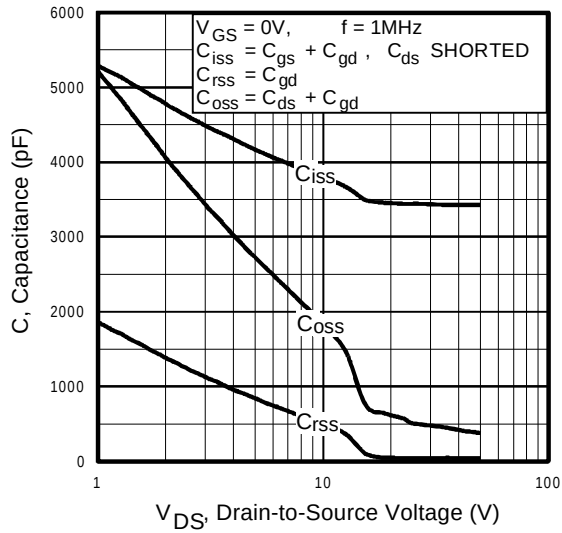
**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$



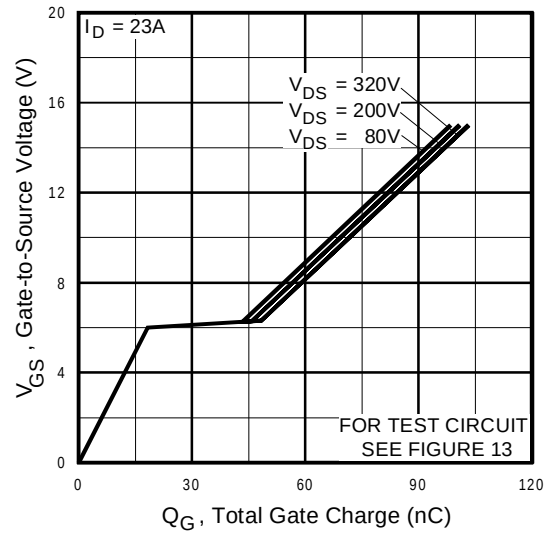
**Fig 3.** Typical Transfer Characteristics



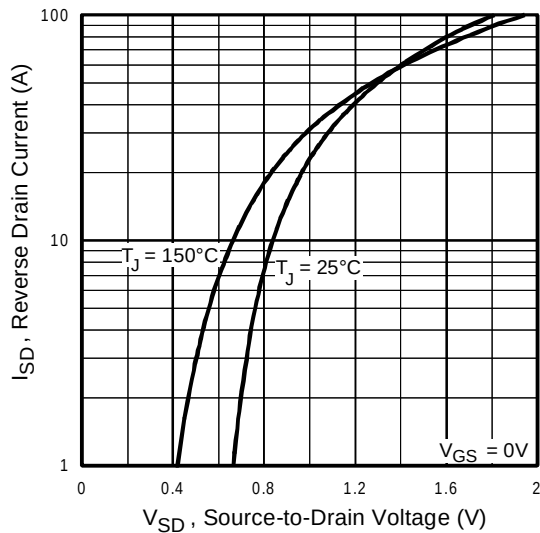
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



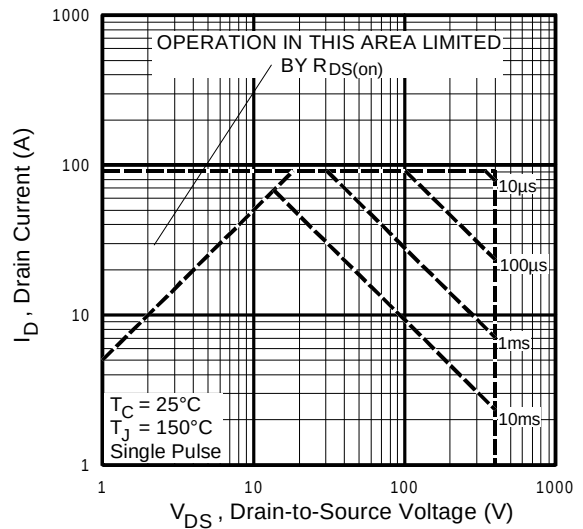
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



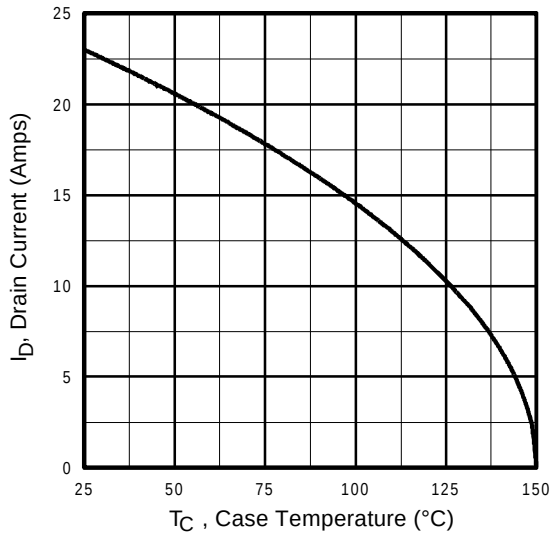
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



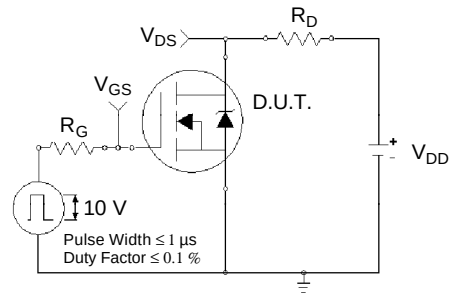
**Fig 7.** Typical Source-Drain Diode Forward Voltage



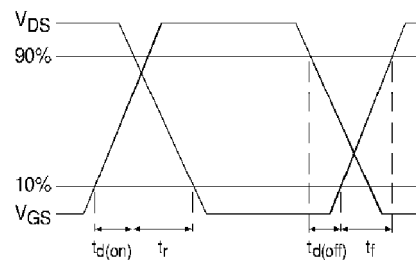
**Fig 8.** Maximum Safe Operating Area



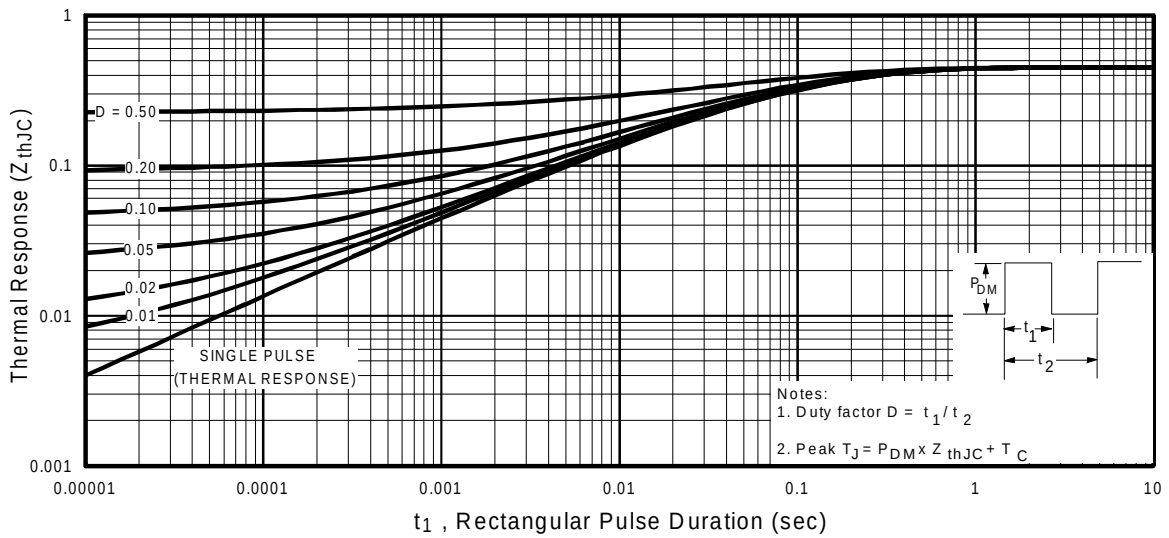
**Fig 9.** Maximum Drain Current Vs. Case Temperature



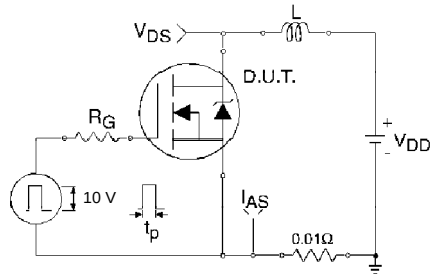
**Fig 10a.** Switching Time Test Circuit



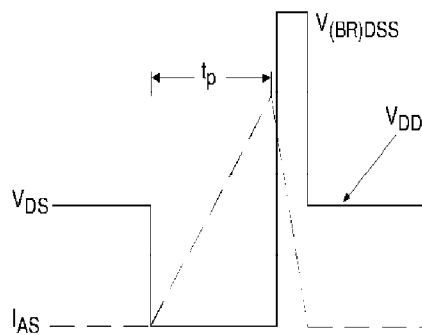
**Fig 10b.** Switching Time Waveforms



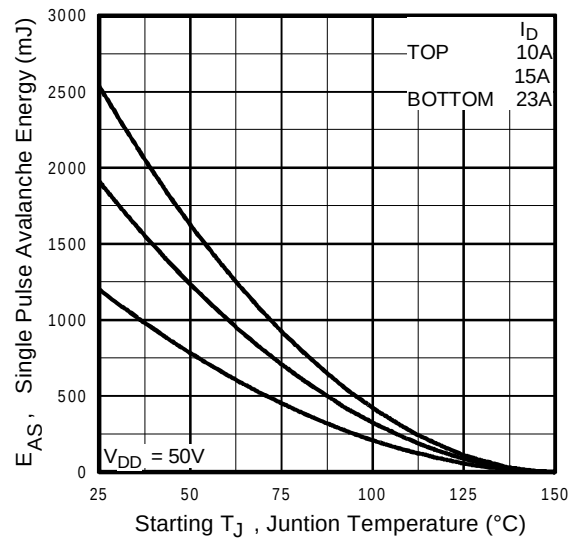
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



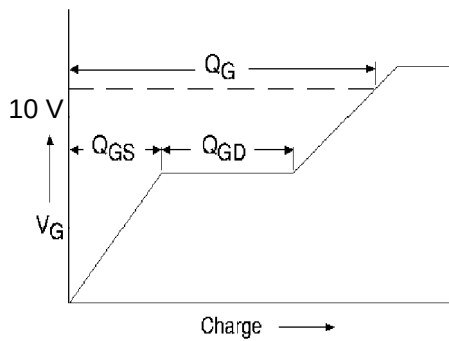
**Fig 12a.** Unclamped Inductive Test Circuit



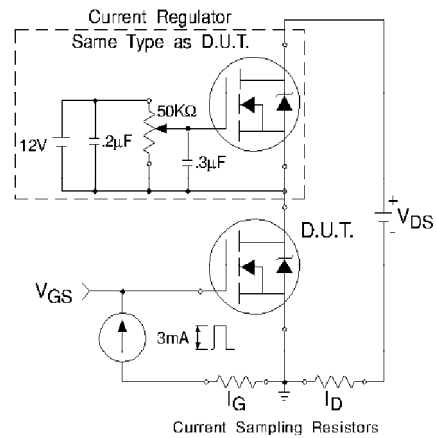
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

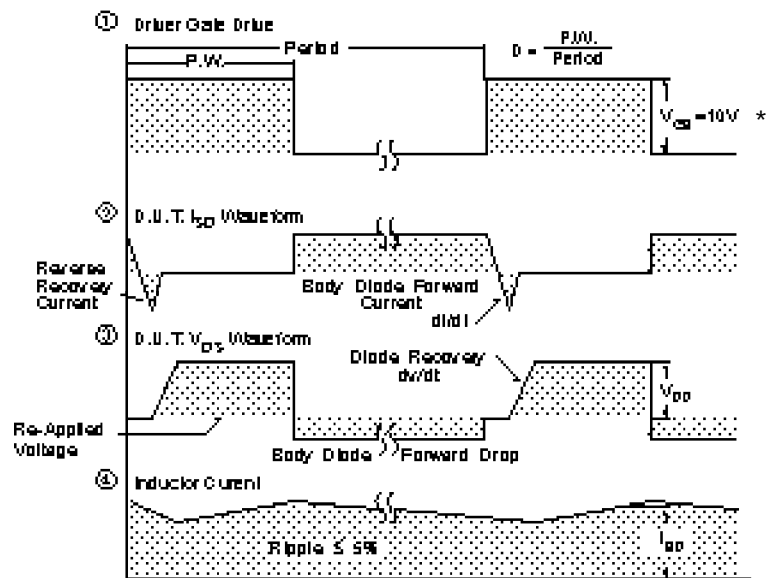
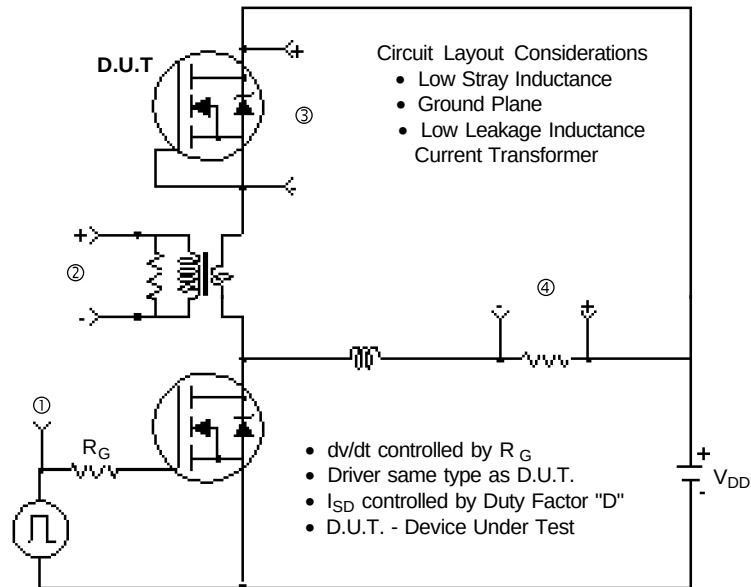


**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 14.** For N-Channel HEXFETS

[illegible]

EXAMPLE : THIS IS AN IRFPE30  
WITH ASSEMBLY  
LOT CODE 3A1Q

The diagram shows a MOSFET package with the following labels and arrows:

- INTERNATIONAL RECTIFIER LOGO**: Points to the IOR logo on the package.
- PART NUMBER**: Points to the IRFPE30 text on the package.
- ASSEMBLY LOT CODE**: Points to the 3A1Q text on the package.
- DATE CODE (YYWW)**: Points to the 9302 text on the package. Below this, it specifies "YY = YEAR" and "WW WEEK".

# International IOR Rectifier

*Data and specifications subject to change without notice.*